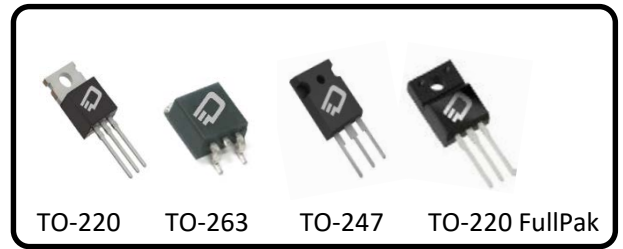


## 650V, 99mΩ, 33.6 A Super Junction Power MOSFET

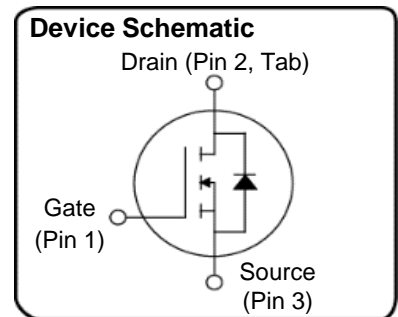
### Ordering Information

Part Number	Package Option
D3S099N65B-U	TO-220
D3S099N65D-U	TO-247
D3S099N65E-T	TO-263
D3S099N65F-U	TO-220 FullPak



### Description

+FET™ is an advanced Super Junction Power MOSFET offering excellent efficiency through low  $R_{DS(ON)}$  and low gate charge. +FET™ is a rugged device with precision charge balance implementation designed for demanding uses such as enterprise power computing power supplies, motor control, lighting and other challenging power conversion applications.



#### Features

- LOW  $R_{DS(ON)}$
- FAST SWITCHING
- HIGH  $E_{AS}$
- REL TEST SPEC: JESD-22
- LOW OUTPUT CAPACITANCE

#### Benefits

- LOW CONDUCTION LOSSES
- HIGH EFFICIENCY
- EXCELLENT AVALANCHE PERFORMANCE

**Table 1 Key Performance Parameters**

Parameters	Value	Unit
$V_{DS} @ T_J \text{ max}$	710	V
$R_{DS(on), \text{max}}$	<99	mΩ
$Q_g, \text{typ}$	56	nC
$I_D @ 25^\circ\text{C}$	33.6	A
$C_{oss}$	72	pf

#### Applications

- POWER FACTOR CORRECTION
- SERVER POWER SUPPLIES
- TELECOM POWER SUPPLIES
- INVERTERS
- MOTOR CONTROL

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@  $T_J = 25^\circ\text{C}$ , unless otherwise specified

**Table 2 Maximum ratings**

Parameter	Symbol	Values				Unit	Note/Test Condition
		Min.	Typ.	Max			
				220, 263 & 247	220FP		
Continuous drain current(1)	$I_D$			33.6	15.9	A	$T_C = 25^\circ\text{C}$
				21.3	10.1		$T_C = 100^\circ\text{C}$
Pulsed drain current(2)	$I_{D,pulse}$			135	63.8	A	$T_C = 25^\circ\text{C}$
Avalanche energy, single pulse	$E_{AS}$			534	534	mJ	$I_D=6.6\text{A}, V_{DD}=50\text{V}$
Avalanche energy, repetitive	$E_{AR}$			1.34	1.34	mJ	$I_D=6.6\text{A}, V_{DD}=50\text{V}$
Avalanche current, repetitive	$I_{AR}$			6.6	6.6	A	
MOSFET dv/dt ruggedness	dv/dt			50	50	V/ns	$V_{DS}=\dots 480\text{V}$
Gate source voltage	$V_{GS}$	-30		30	30	V	static
		-30		30	30		AC (f > 1HZ)
Power dissipation for TO-220	$P_{tot}$			272	61	W	$T_C = 25^\circ\text{C}$
Operating and storage temperature	$T_J, T_{stg}$	-55		150	150	$^\circ\text{C}$	
Mounting torque				60		Ncm	M3 and M3.5 screws
					50		M3 screws
Continuous diode forward current	$I_S$			33.6	15.9	A	$T_C = 25^\circ\text{C}$
Diode pulsed current	$I_{S,pulse}$			135	63.8	A	$T_C = 25^\circ\text{C}$
Reverse diode dv/dt(3)	dv/dt			15	15	V/ns	$V_{DS}=\dots 480\text{V}, I_{SD}<I_D$ $T_J = 25^\circ\text{C}$
Maximum diode commutation speed	dif/dt			500	500	A/us	

**Table 3 Thermal characteristics**

Parameter	Symbol	Values				Unit	Note/Test Condition
		Min.	Typ.	Max			
				220, 263 & 247	220FP		
Thermal resistance, Junction-case	$R_{thJC}$			0.5	2.25	$^\circ\text{C}/\text{W}$	
Thermal resistance, Junction-ambient	$R_{thJA}$			43.4	46	$^\circ\text{C}/\text{W}$	Leaded
Soldering temperature, wavesoldering only allowed at leads	$T_{sold}$			260	260	$^\circ\text{C}$	1.6mm form case for 10s

**Table 4 Static characteristics**

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Drain to source breakdown voltage	$V_{(BR)DSS}$	650			V	$V_{GS}=0V, I_D=1mA$
Gate threshold voltage	$V_{GS(TH)}$	2.3	3.2	4.5	V	$V_{DS}=V_{GS}, I_D=194\mu A$
Zero gate voltage drain current	$I_{DSS}$			1	uA	$V_{DS}=650V, V_{GS}=0V, T_J = 25^\circ C$
				40		$V_{DS}=650V, V_{GS}=0V, T_J = 150^\circ C$
Gate to source leakage current	$I_{GSS}$			100	nA	$V_{GS}=\pm 20V, V_{DS}=0V$
Drain-source on-state resistance	$R_{DS(on)}$		94	99	m $\Omega$	$V_{GS}=10V, I_D=16.8A, T_J = 25^\circ C$
			190		m $\Omega$	$V_{GS}=10V, I_D=16.8A, T_J = 150^\circ C$
Gate resistance	$R_G$		1		$\Omega$	Scaf-F

**Table 5 Dynamic characteristics**

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Input capacitance	$C_{iss}$		2222		pF	$V_{GS}=0V, V_{DS}=100V, f=1MHz$
Output capacitance	$C_{oss}$		72		pF	
Reverse transfer capacitance	$C_{rss}$		13		pF	
Effective output capacitance, energy related 1	$C_{o(er)}$		105		pF	$V_{DS}=0\dots 480V, V_{GS}= 0V$
Effective output capacitance, time related 2	$C_{o(tr)}$		331		pF	$I_D=constant, V_{DS}=0\dots 480V, V_{GS}= 0V$
Turn on delay time	$t_{d(on)}$		18		ns	$V_{DD}=400V, I_D=16.8A, R_G=1.0\Omega, V_{GS}=10V$
Rising time	$t_r$		25		ns	
Turn off delay time	$t_{d(off)}$		41		ns	
Fall time	$t_f$		22		ns	

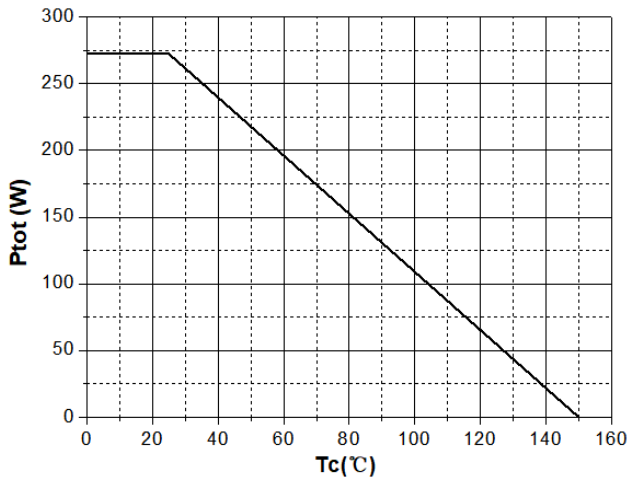
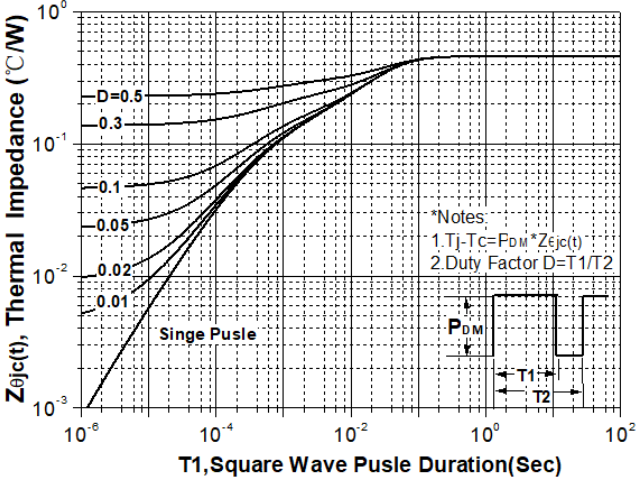
**Table 6 Gate charge characteristics**

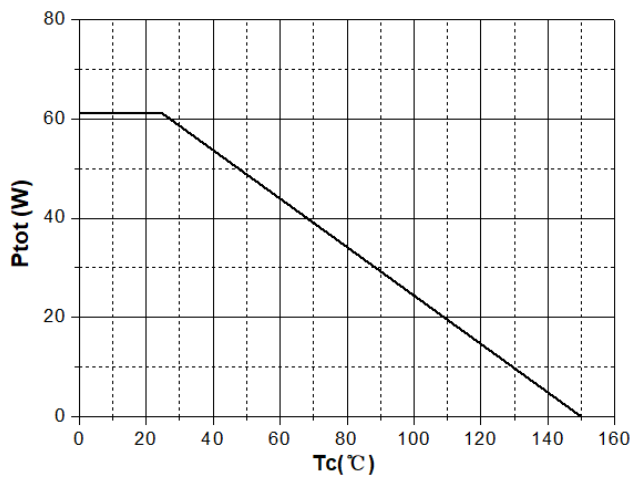
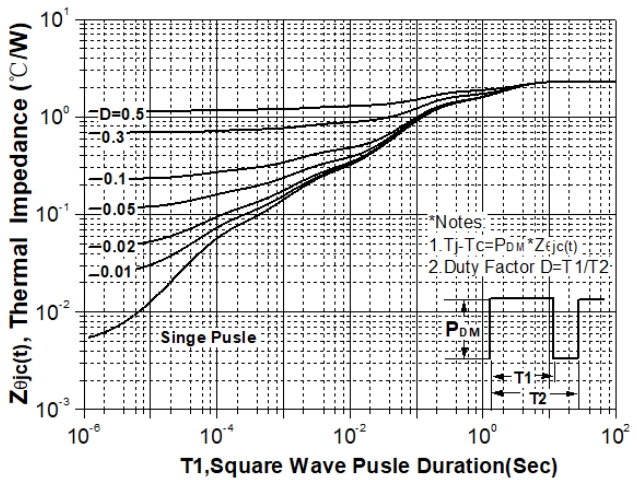
Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Total gate charge	$Q_g$		56		nC	$V_{DD}=480V, V_{GS}=0 \text{ to } 10V, I_D=16.8A$
Gate-source charge	$Q_{gs}$		14		nC	
Gate-drain charge	$Q_{gd}$		23		nC	
Gate plateau voltage	$V_{plateau}$		5.0		V	

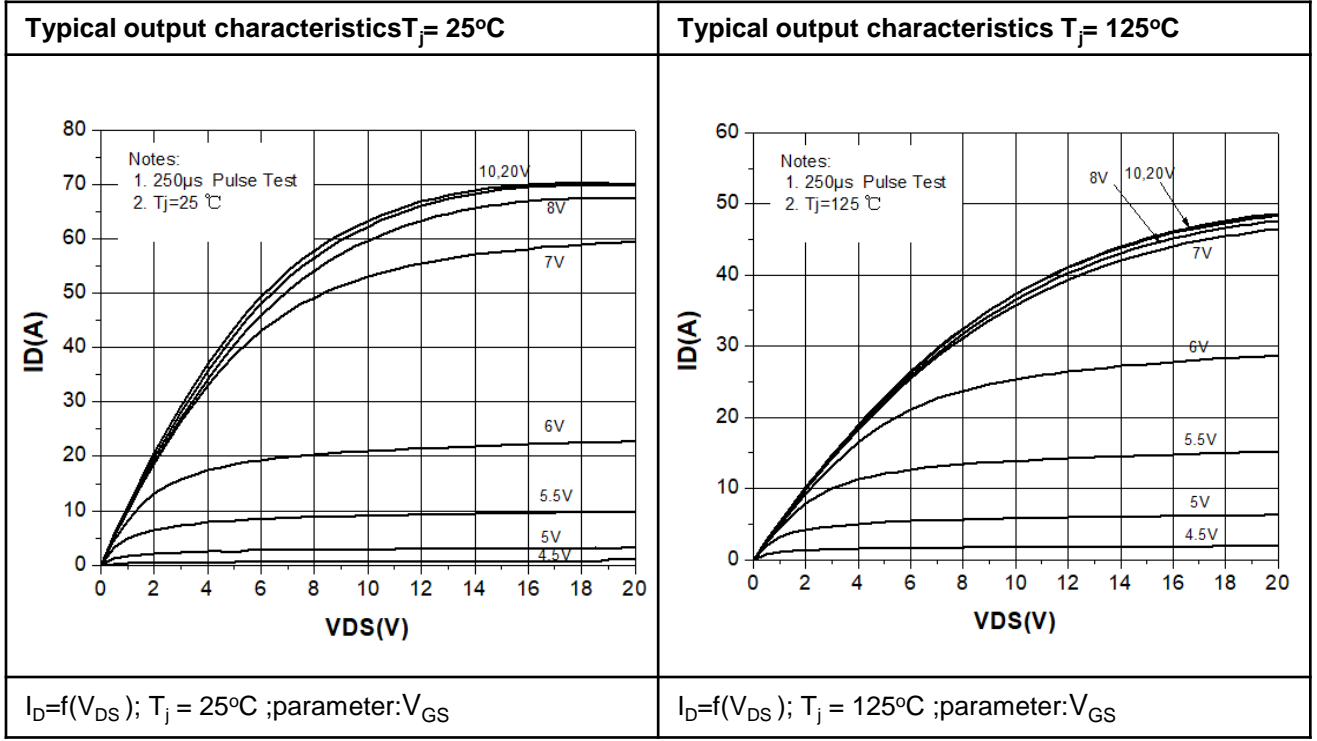
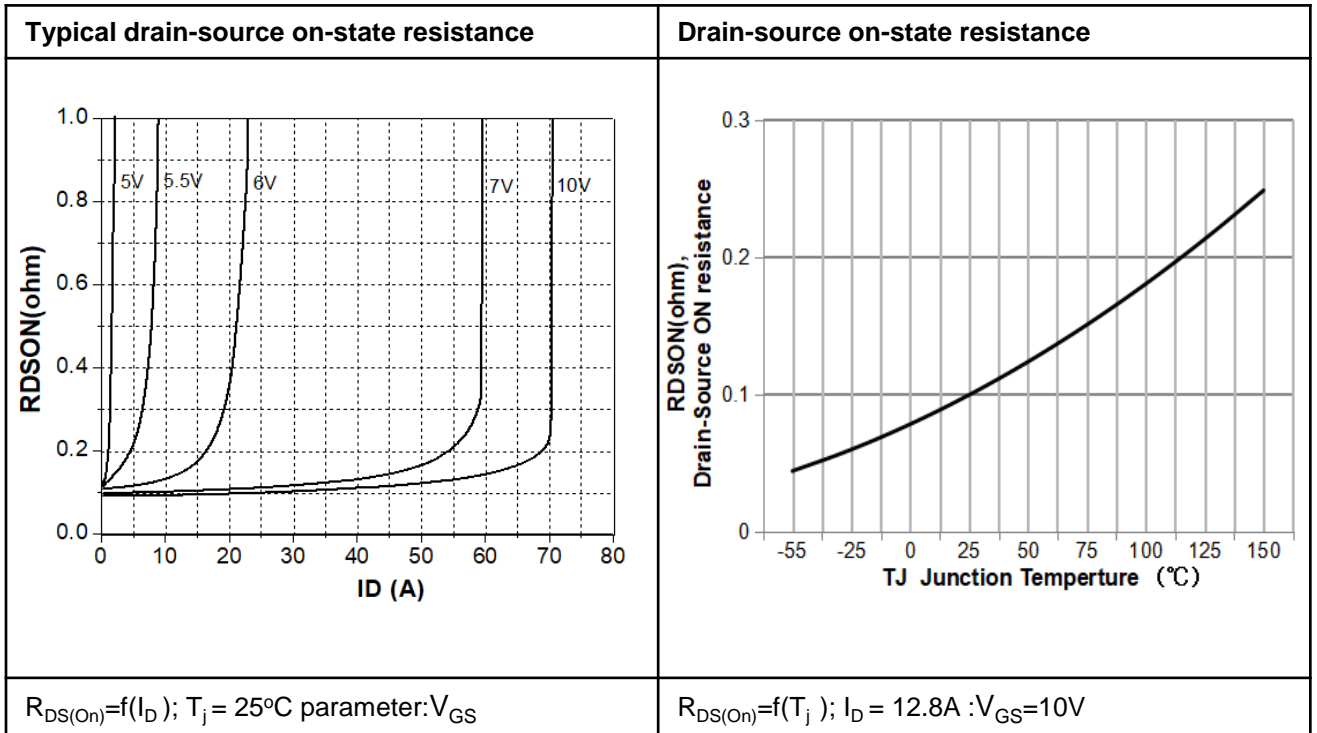
**Table 7 Reverse diode characteristics**

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min	Typ	Max		
Diode forward voltage	$V_{SD}$		0.87	0.96	V	$I_F=33.6A, V_{GS}=0V, T_J = 25^\circ C$
Reverse recovery time	$t_{rr}$		452		ns	$I_F=33.6A, dI_F/dt=100A/us$
Reverse recovery charge	$Q_{rr}$		8.0		uC	
Peak reverse recovery current	$I_{rrm}$		36		A	

**Table 8 Thermal Performance**

Power dissipation (TO220, TO263 & TO247)	Max. transient thermal impedance (TO220, TO263 & TO247)
	
$P_{tot} = f(T_C)$	$Z_{thJC} = f(t_p); \text{parameter: } D = t_p/T$

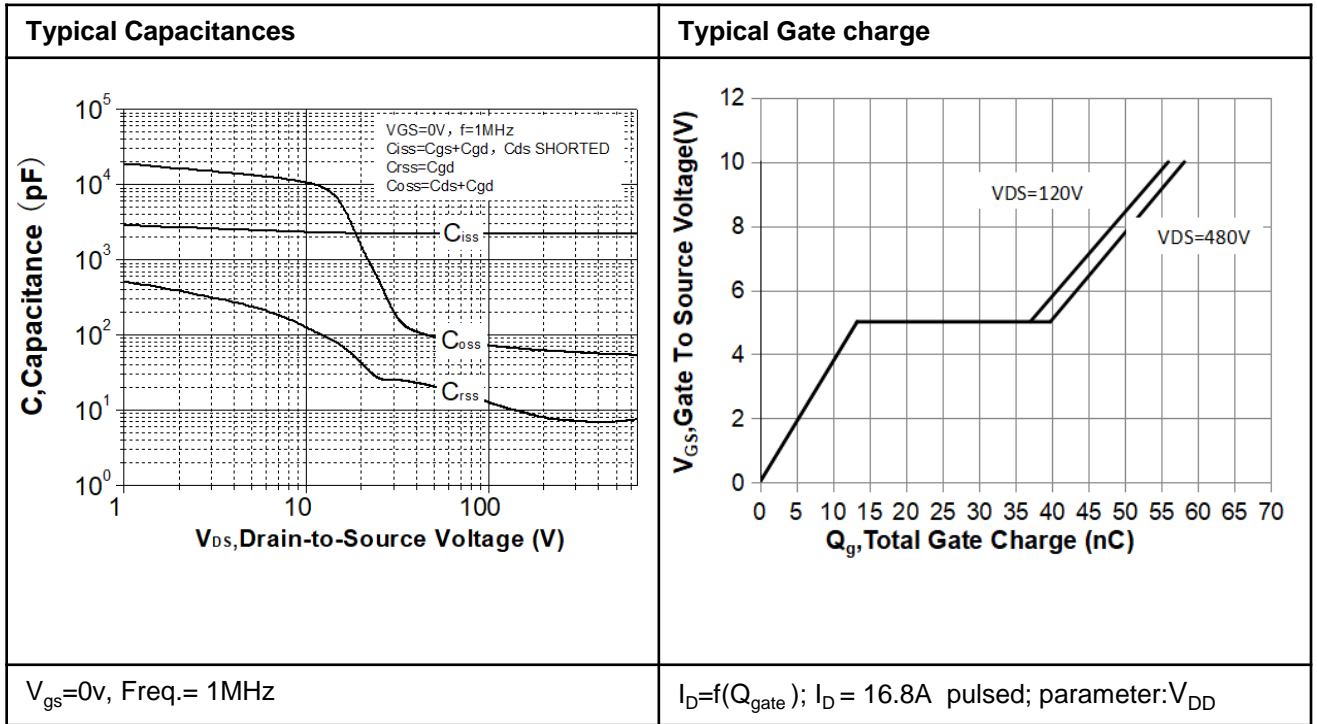
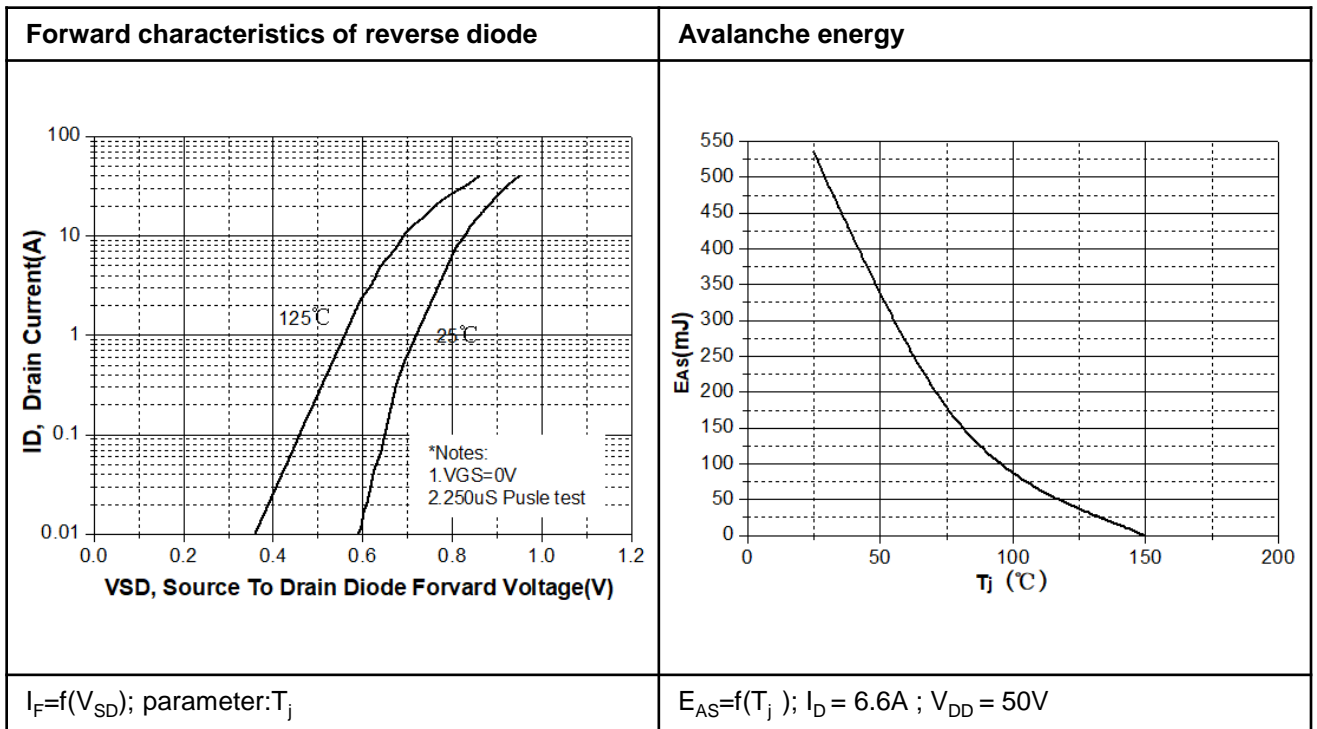
Power dissipation (TO220F)	Max. transient thermal impedance (TO220F)
	
$P_{tot} = f(T_C)$	$Z_{thJC} = f(t_p); \text{parameter: } D = t_p/T$

**Table 9 Output Characteristics**

**Table 10 Drain Source Resistance**


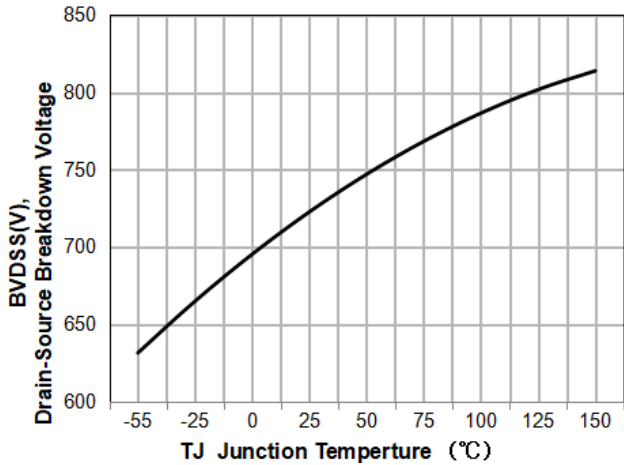
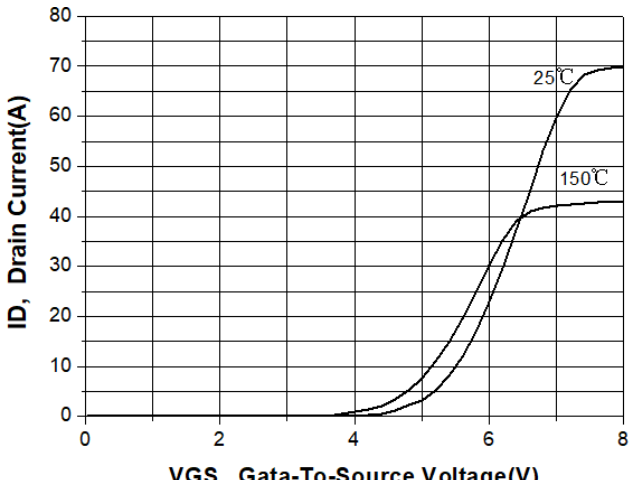
**Table 11 Safe Operating Area**

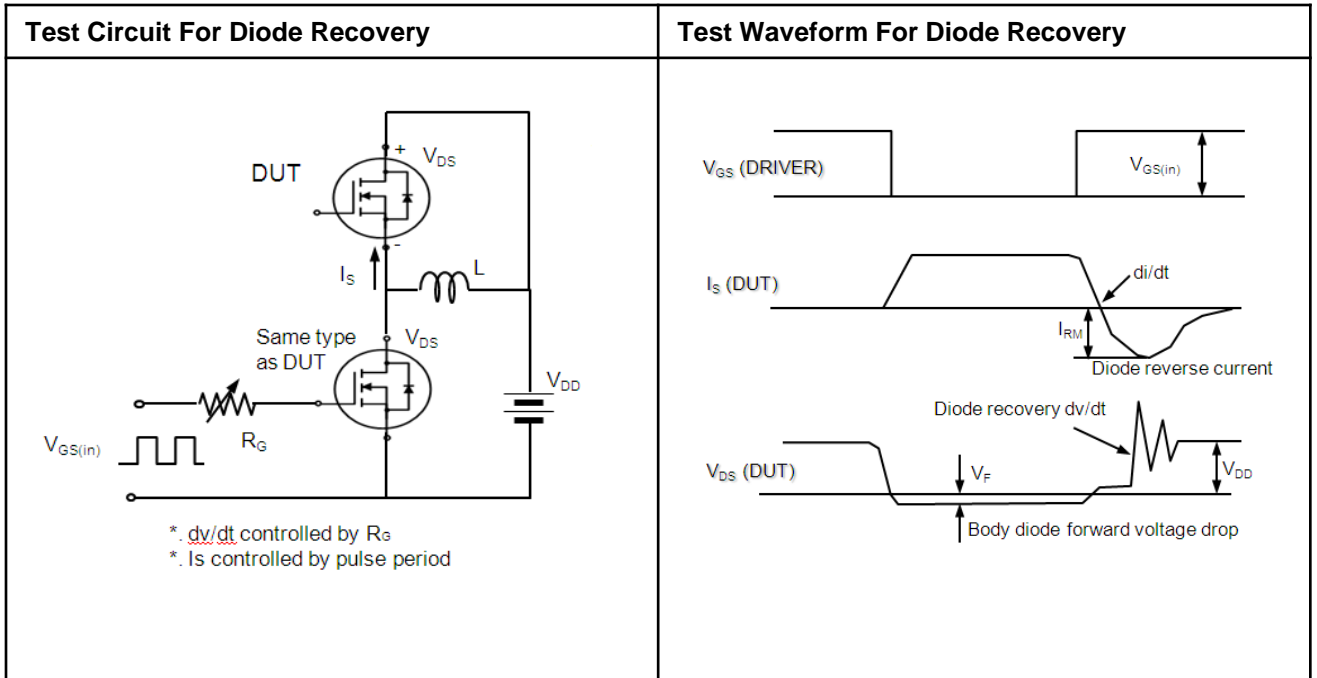
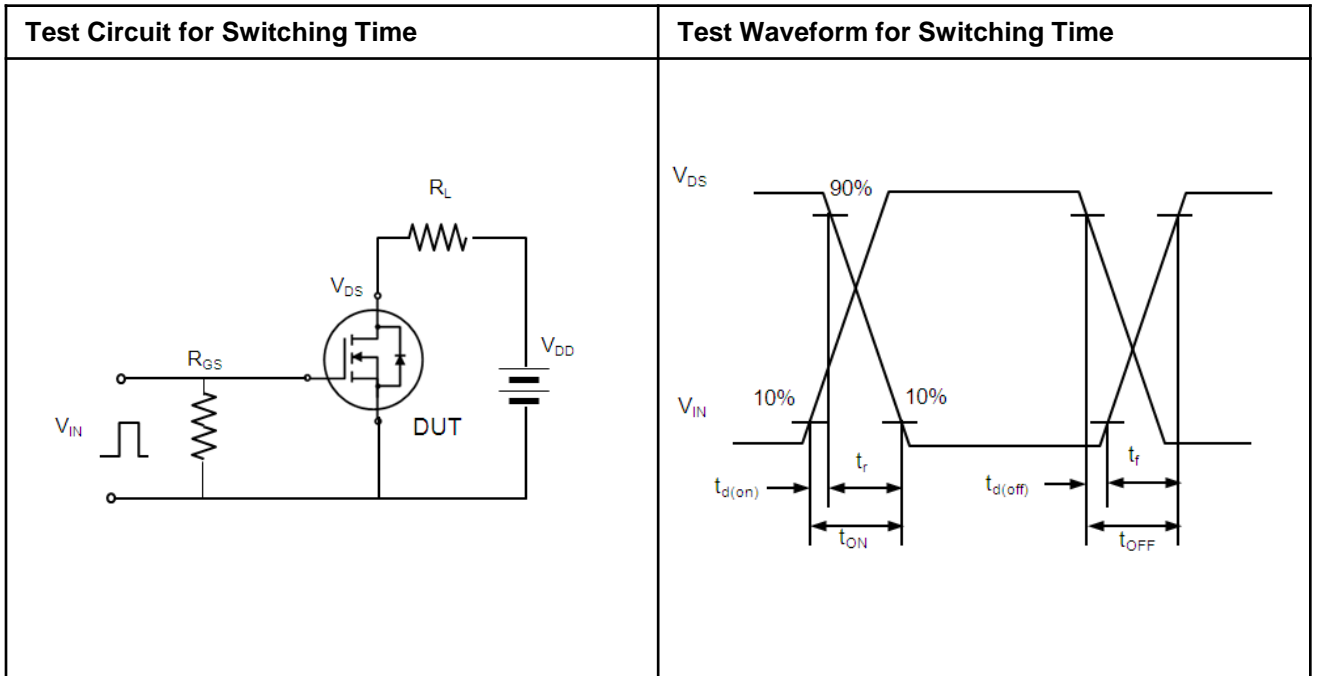
Safe operating area $T_C = 25^\circ\text{C}$ (TO220, TO263 & TO247)	Safe operating area $T_C = 80^\circ\text{C}$ (TO220, TO263 & TO247)
$I_D = f(V_{DS}); T_C = 25^\circ\text{C}; D=0; \text{parameter: } t_p$	$I_D = f(V_{DS}); T_C = 80^\circ\text{C}; D=0; \text{parameter: } t_p$
Safe operating area $T_C = 25^\circ\text{C}$ (TO220F)	Safe operating area $T_C = 80^\circ\text{C}$ (TO220F)
$I_D = f(V_{DS}); T_C = 25^\circ\text{C}; D=0; \text{parameter: } t_p$	$I_D = f(V_{DS}); T_C = 80^\circ\text{C}; D=0; \text{parameter: } t_p$



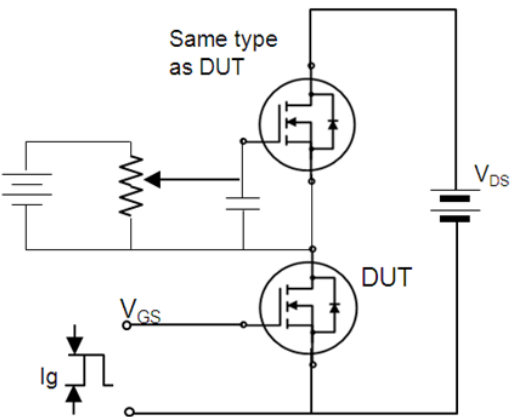
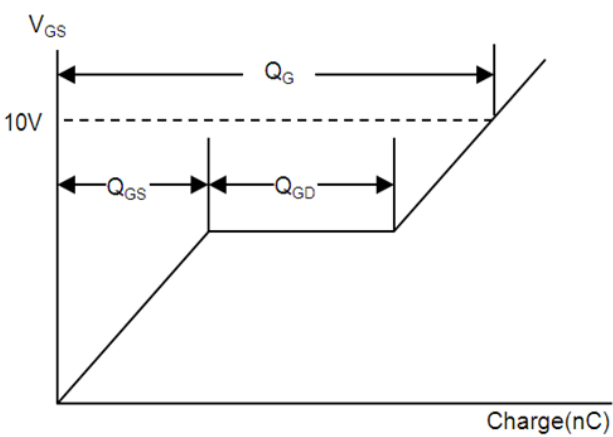
**Table 12 Capacitances and Gate Charge**

**Table 13 Diode Characteristics and Avalanche Energy**


**Table 14 Breakdown Voltage and Transfer Characteristics**

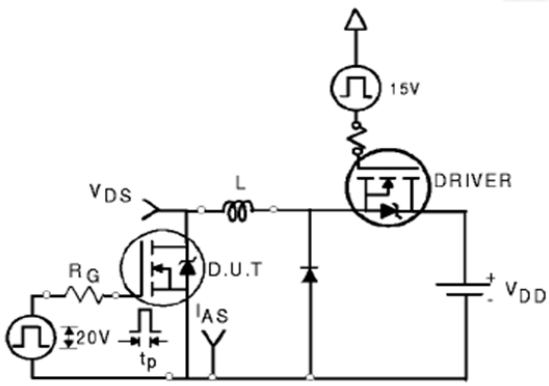
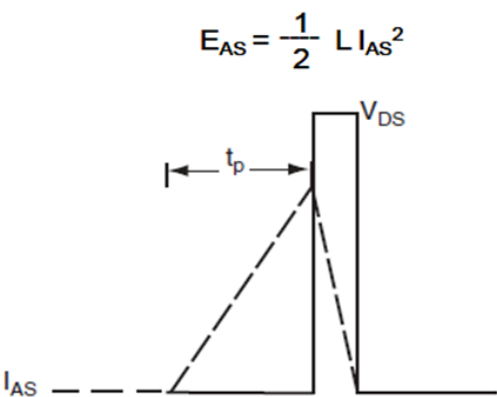
Drain-source breakdown voltage	Transfer Characteristics
 <p>The graph shows the Drain-Source Breakdown Voltage (BV<sub>DSS</sub>) in Volts (V) on the y-axis (ranging from 600 to 850) versus the TJ Junction Temperature in degrees Celsius (°C) on the x-axis (ranging from -55 to 150). The curve shows a non-linear increase in breakdown voltage with temperature, starting at approximately 630V at -55°C and reaching about 815V at 150°C.</p>	 <p>The graph shows the Drain Current (I<sub>D</sub>) in Amperes (A) on the y-axis (ranging from 0 to 80) versus the Gate-To-Source Voltage (V<sub>GS</sub>) in Volts (V) on the x-axis (ranging from 0 to 8). Two curves are shown for different temperatures: 25°C and 150°C. The 25°C curve shows a higher drain current for a given gate voltage compared to the 150°C curve, indicating a decrease in transconductance with increasing temperature.</p>
$V_{BR(DSS)} = f(T_j); I_D = 1mA$	$I_D = f(V_{GS});  V_{DS}  > 2 I_D R_{DS(On)max}; parameter: T_j$

**Table 15 Diode Recovery Characteristic**

**Table 16 Switching Time Characteristic**


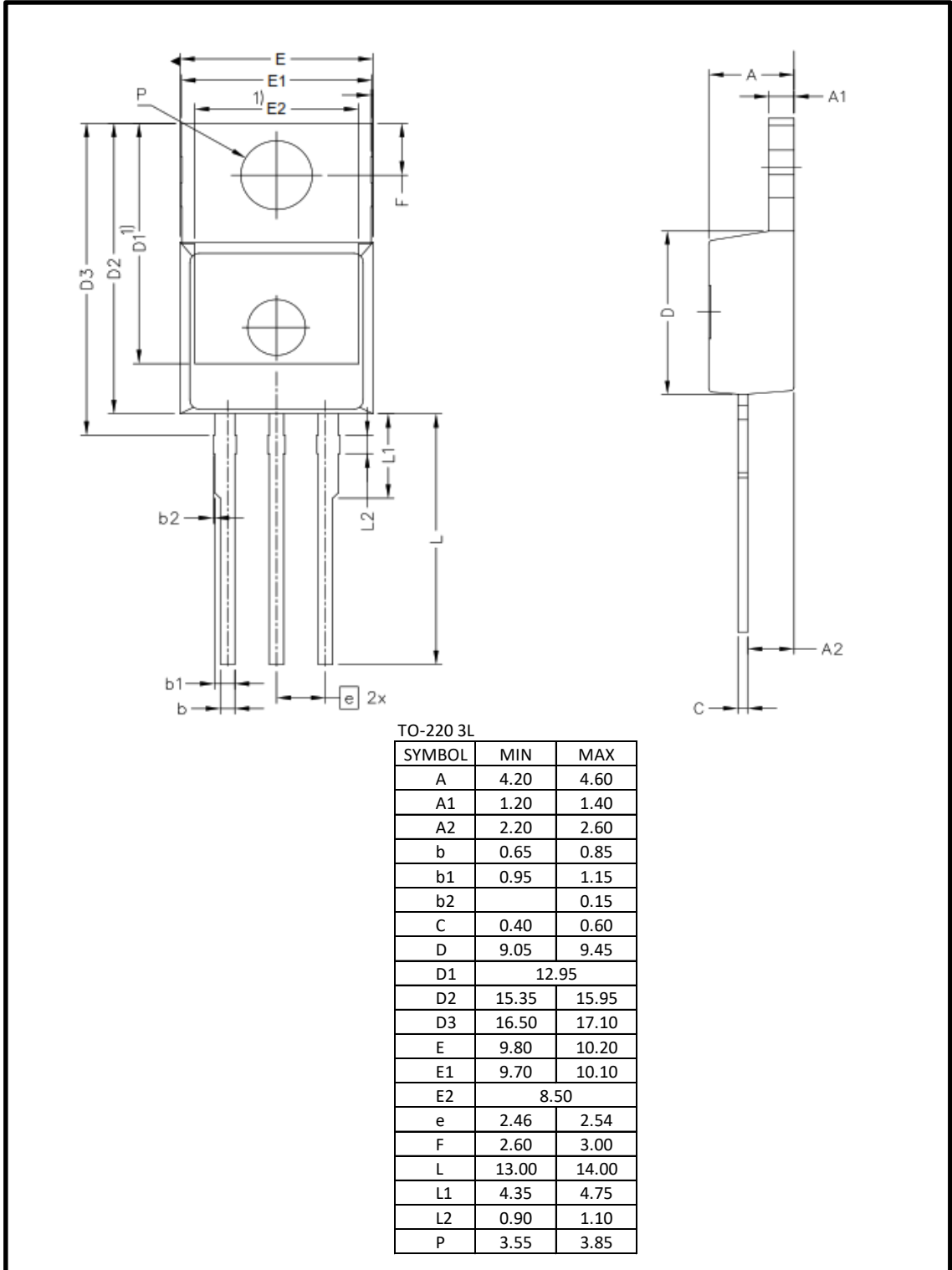
**Table 17 Gate Charge Characteristic**

Test Circuit For Gate Charge	Test Waveform For Gate Charge
	

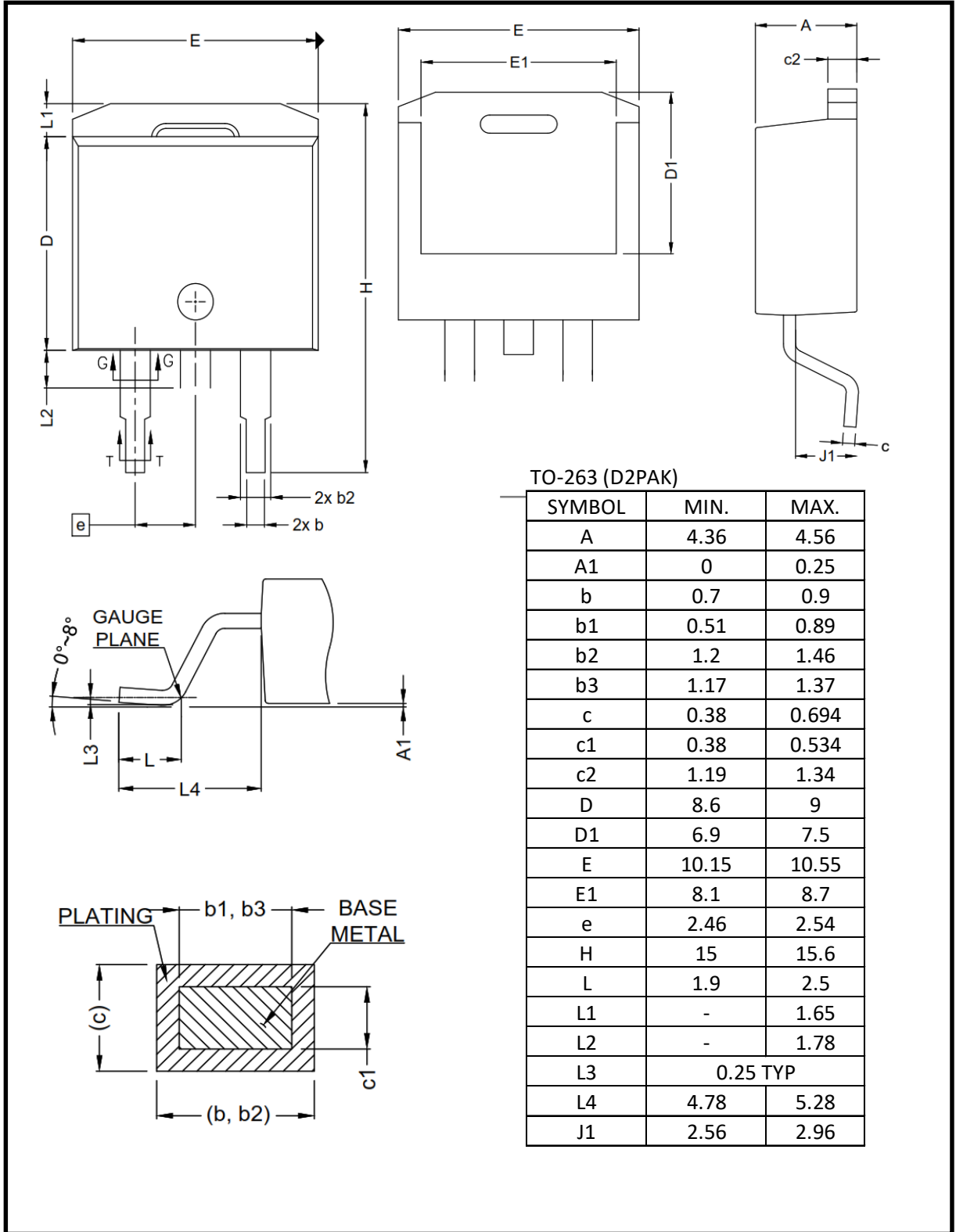
**Table 18 Unclamped Inductive Characteristic**

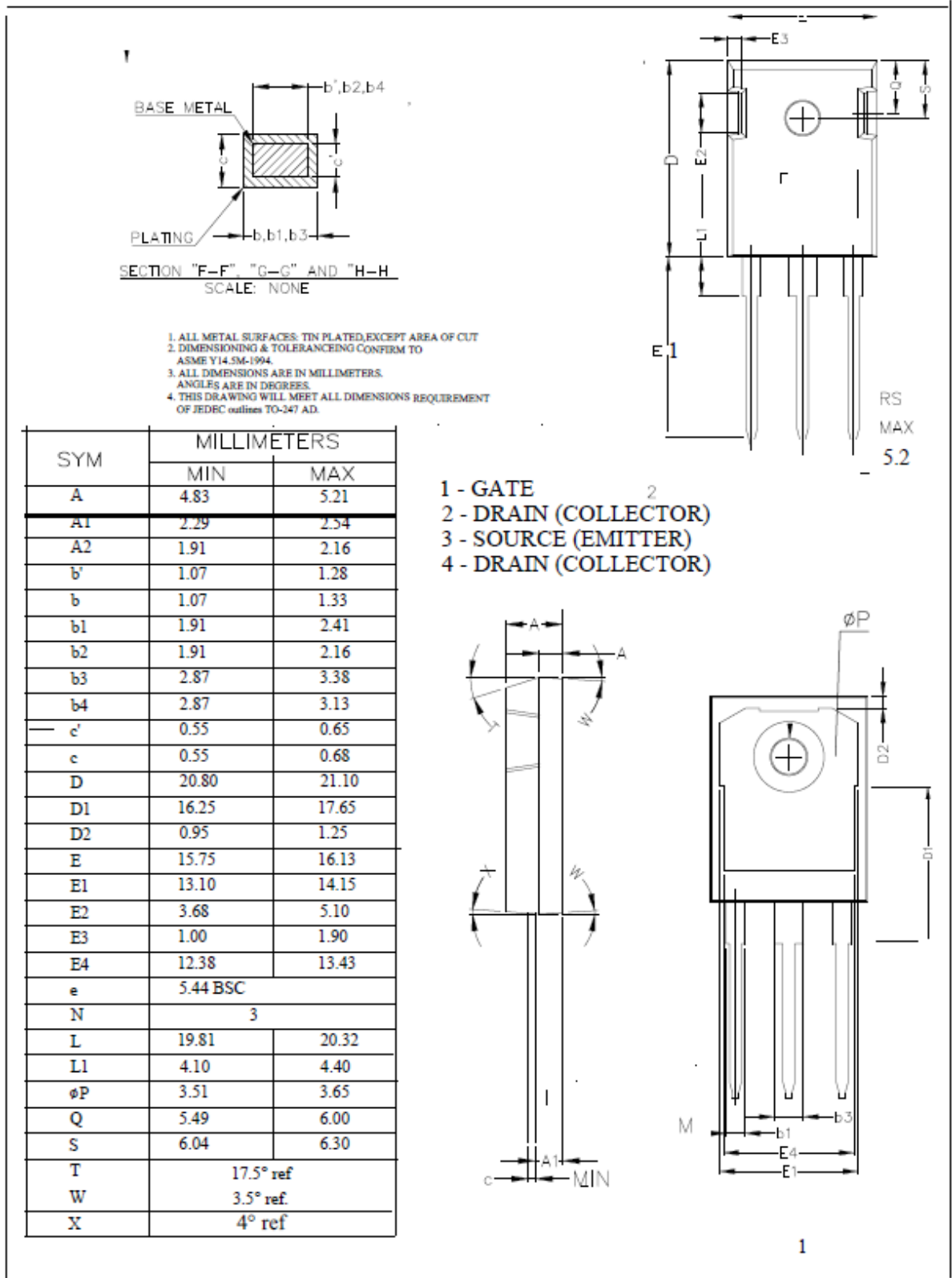
Test Circuit For Unclamped Inductive	Test Waveform For Unclamped Inductive
	 $E_{AS} = \frac{1}{2} L I_{AS}^2$

### 4a) TO-220

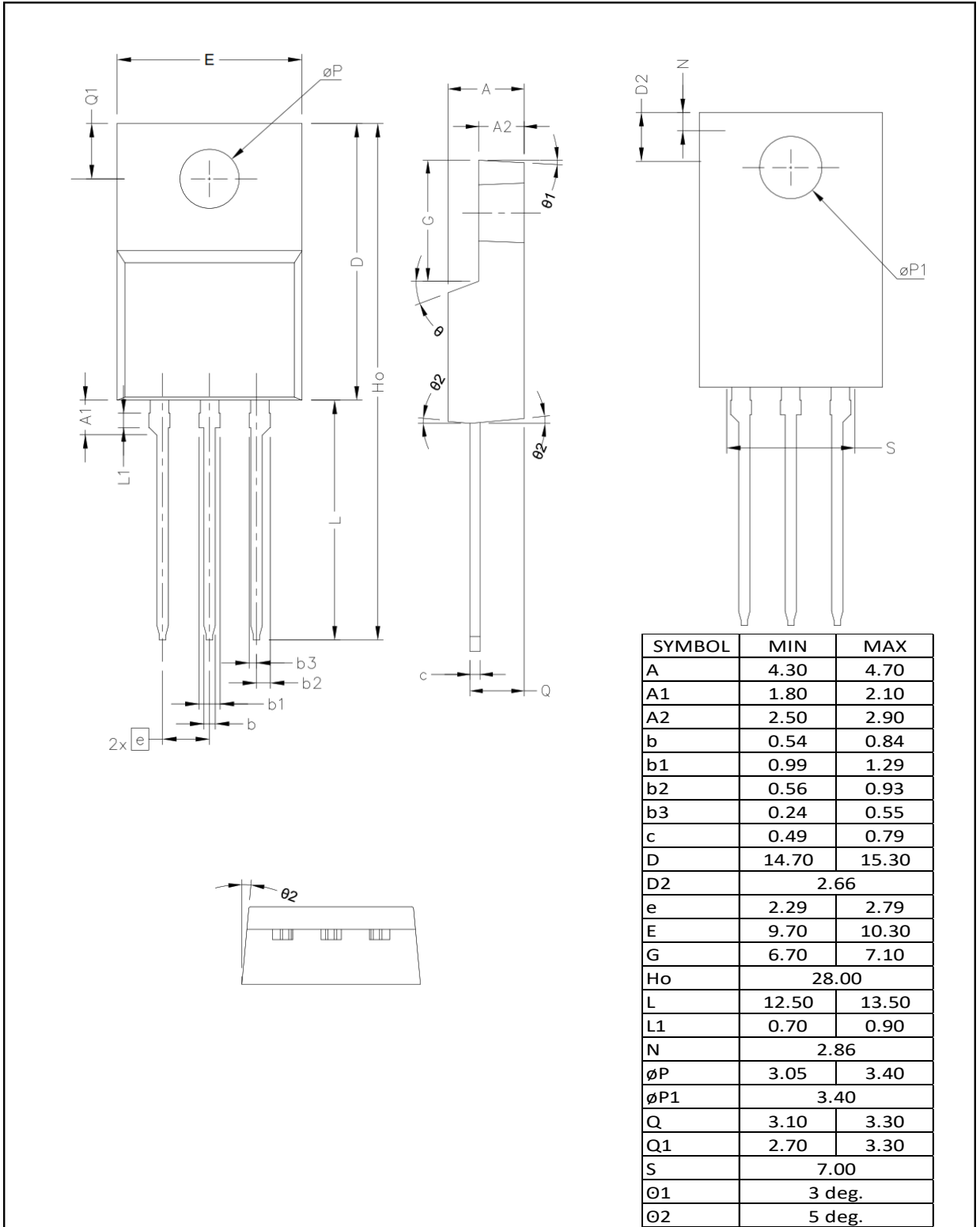


4b) TO-263



**4c) TO-247**


**4d) TO-220 FullPak**





## Revision History

Revision	Release Date	Comments
1.0	1-Nov-2016	Preliminary Datasheet Draft
2.0	1-July-2017	Update tables and package detail
2.5	20-Nov-2017	Added TO247 Package
2.6	11-Dec-2017	Added Test Circuits
3.0	2-Jan 2019	Updated/update tables and charts


## Resources

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